
Lecture13:

MOSFET, small-signal model

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Review on MOSFET IV

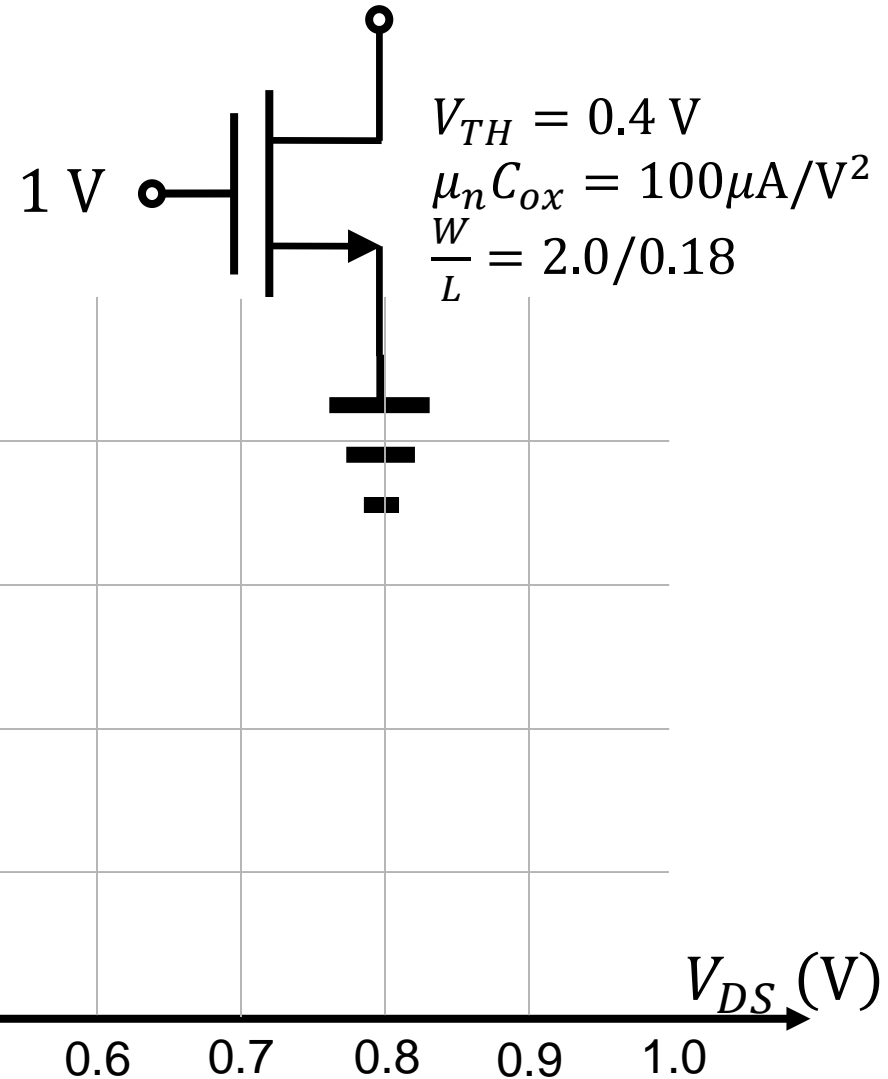
- When $V_G < V_{TH}$,
 - No drain current!

$$I_D = 0$$

- When $V_G > V_{TH}$,
 - Triode mode ($V_{DS} < V_G - V_{TH}$)
$$I_D = \mu_n C_{ox} \frac{W}{L} \left[(V_G - V_{TH}) V_{DS} - \frac{1}{2} V_{DS}^2 \right]$$
 - Saturation mode ($V_{DS} > V_G - V_{TH}$)
$$I_D = \frac{1}{2} \mu_n C_{ox} \frac{W}{L} (V_G - V_{TH})^2$$
 - For a short channel device, I_D increases slightly as V_{DS} increases.

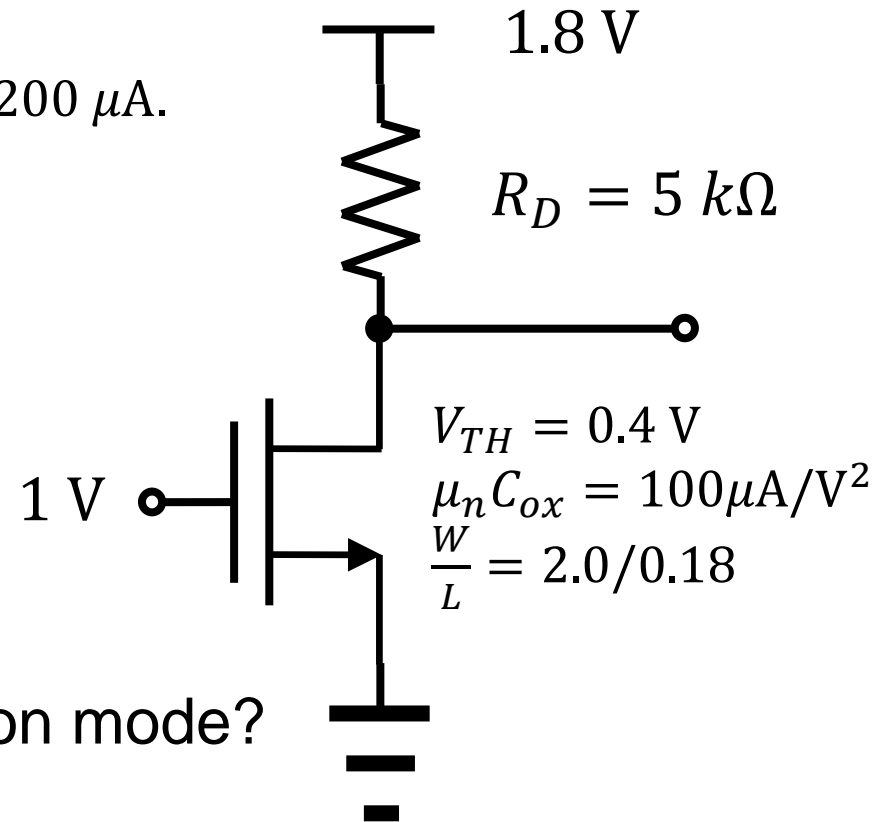
An example

- Draw $I_D - V_{DS}$ at $V_{GS} = 1\text{ V}$.
 - What is the saturation current?



Example 6.6 (Razavi)

- Assume the saturation region.
 - The saturation current becomes $200\ \mu\text{A}$.
 - Then, the drain voltage is



- Is the MOSFET in the saturation mode?
- Graphical visualization

V_{out} versus V_{in}

- A table

V_{in} (V)	V_{out} (V)
0.0	1.8
<0.4	1.8
0.7	1.55
1.0	0.8
X	$X - 0.4$
1.8	Y

- What are the values of X and Y ?

MOS transconductance

- “conductance” of a simple resistor: $\partial I / \partial V = I / V$
- “trans” + “conductance” between different terminals

$$g_m = \frac{\partial I_D}{\partial V_{GS}} \quad (\text{Razavi 6.44})$$

- For the saturation region,

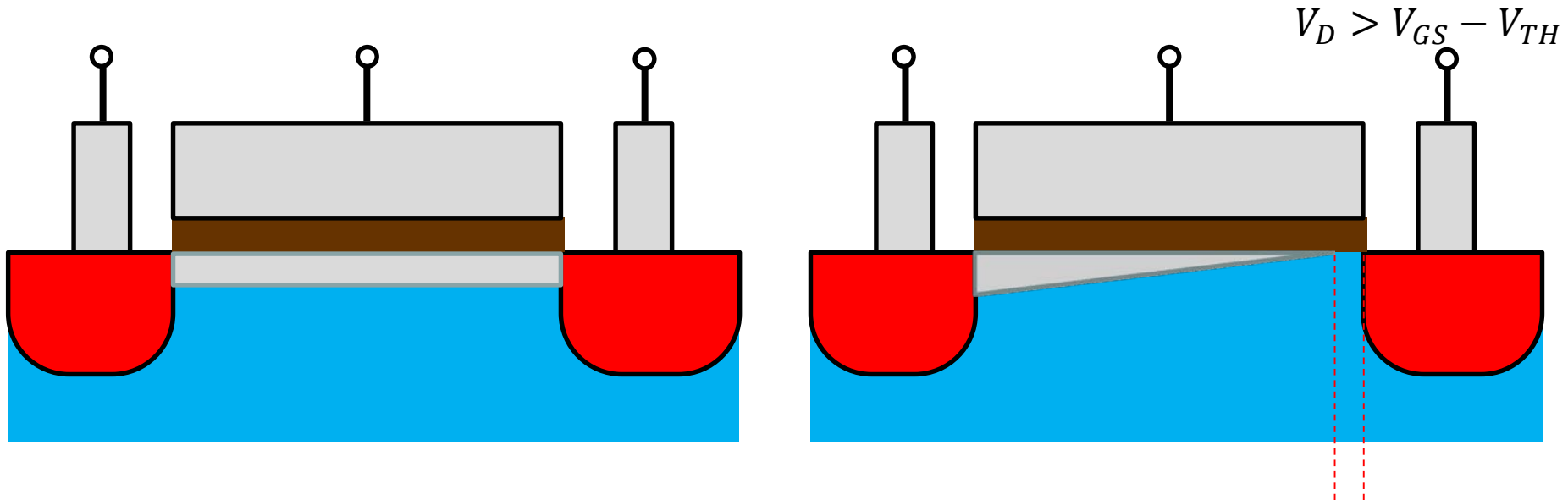
$$g_m = \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH})$$

$$g_m = \sqrt{2\mu_n C_{ox} \frac{W}{L} I_D}$$

$$g_m = \frac{2I_D}{V_{GS} - V_{TH}}$$

Channel length modulation

- Channel length modulation

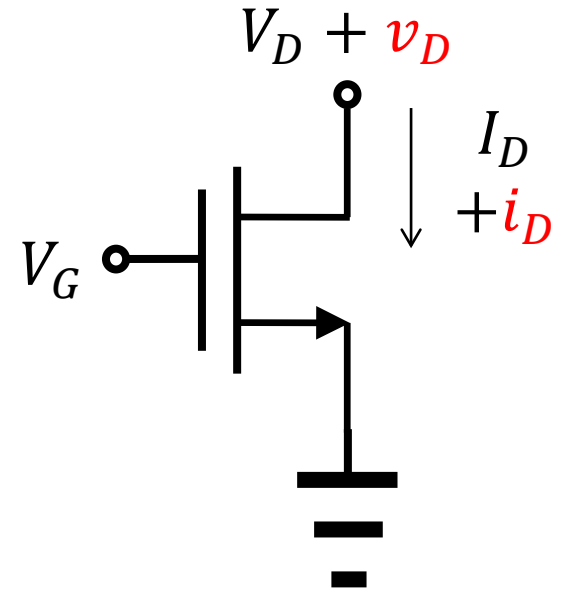
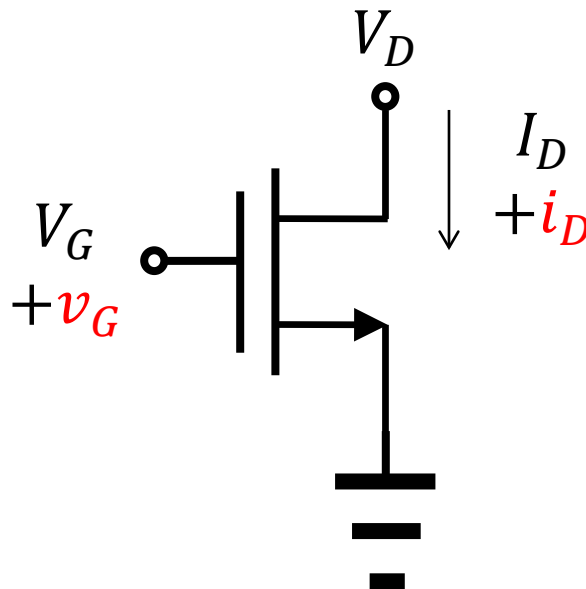
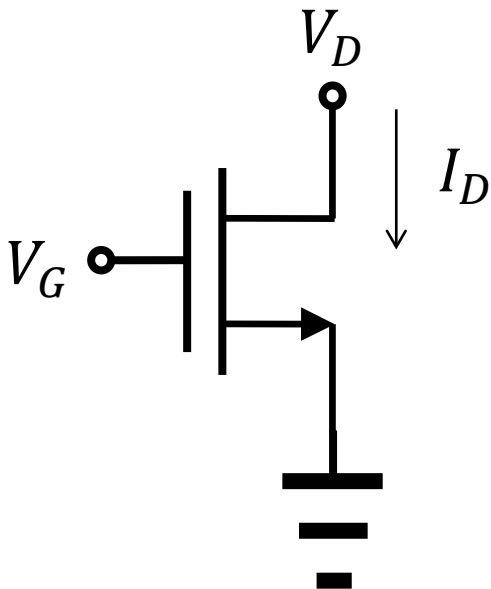


- Output resistance?

$$r_o = \frac{\Delta V_{DS}}{\Delta I_D}$$

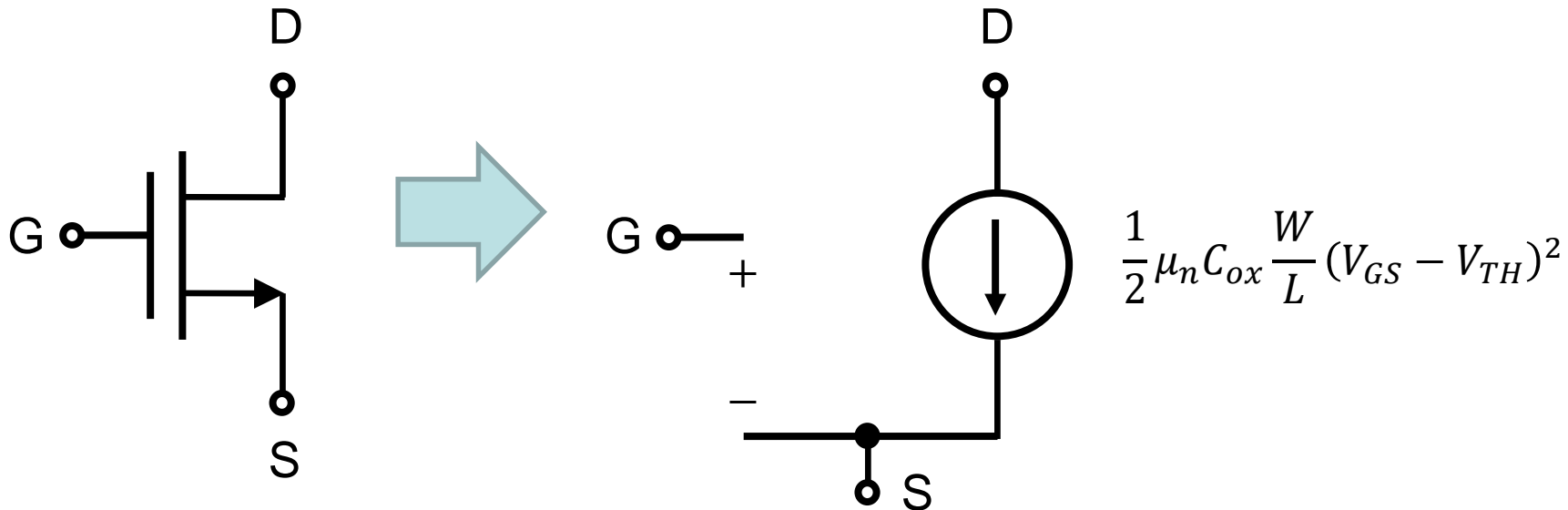
Derivatives

- We can define two derivatives.
 - Transconductance, g_m . Output resistance, r_o .



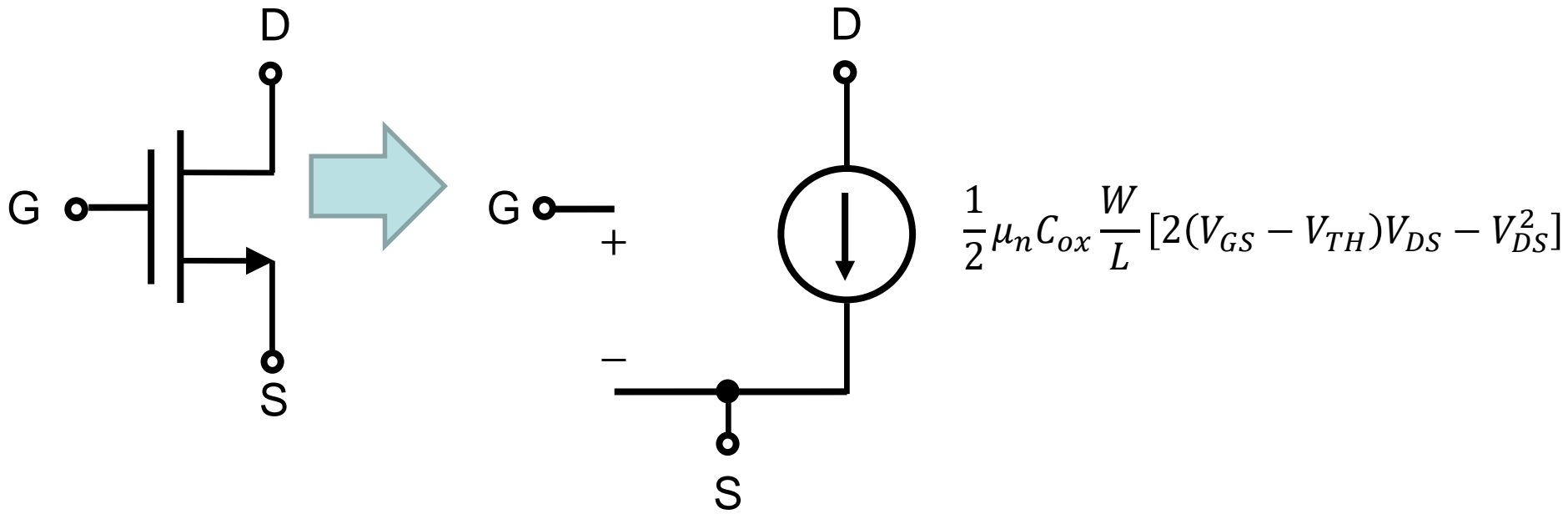
Large-signal model (1/2)

- Saturation region
 - Drain current is determined by gate voltage. (*voltage-controlled current source*)



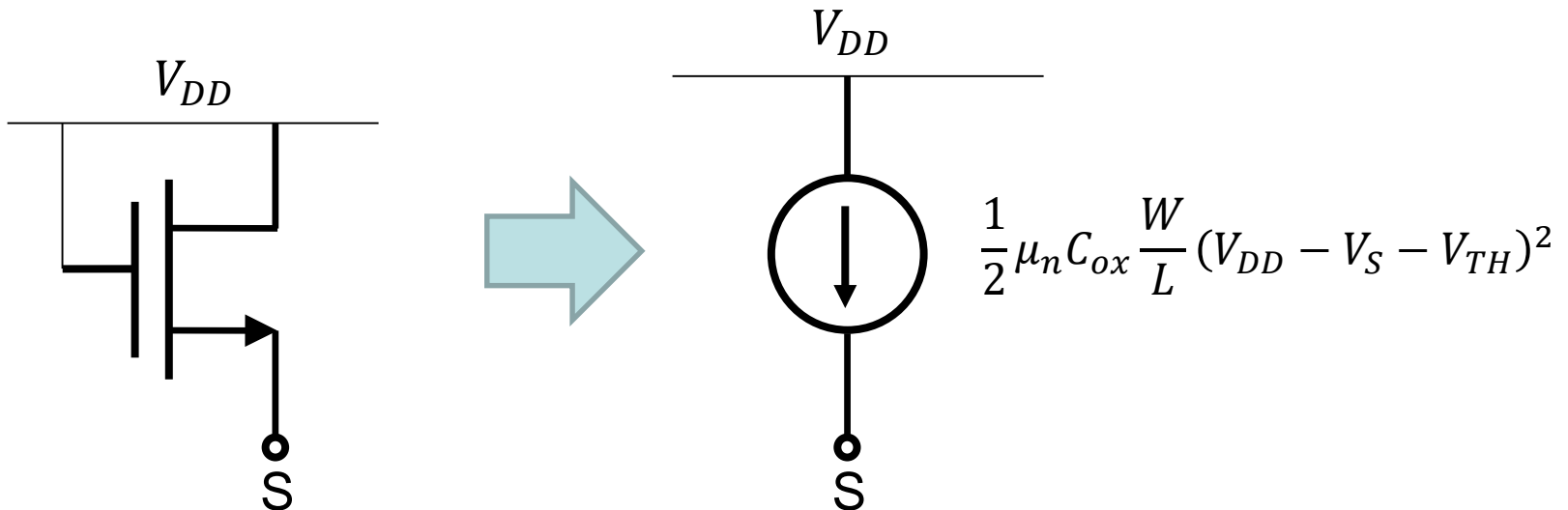
Large-signal model (2/2)

- Triode region
 - Still, it can be described by a *voltage-controlled current source*.



Example 6.13 (Razavi)

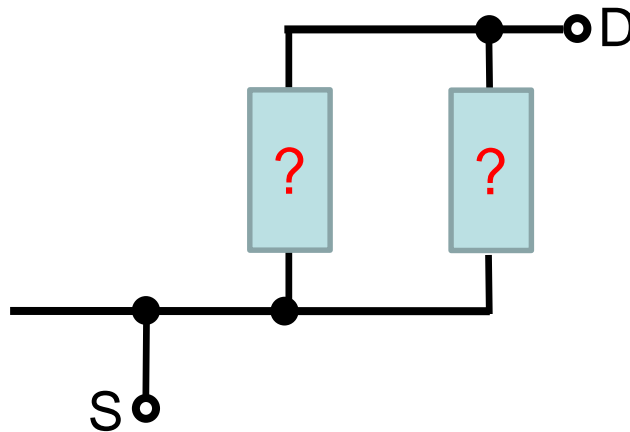
- Always in the saturation region!
 - Any necessary condition?



Gate and drain are tied.
They are connected to V_{DD} .

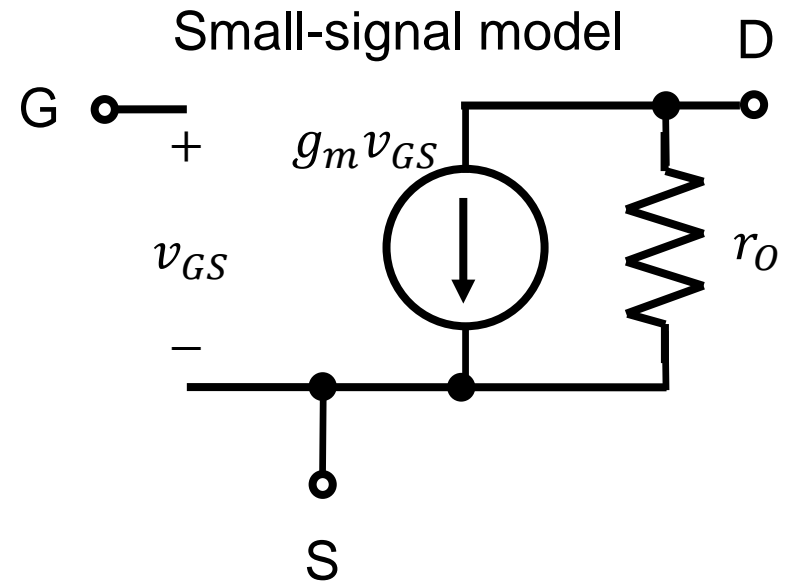
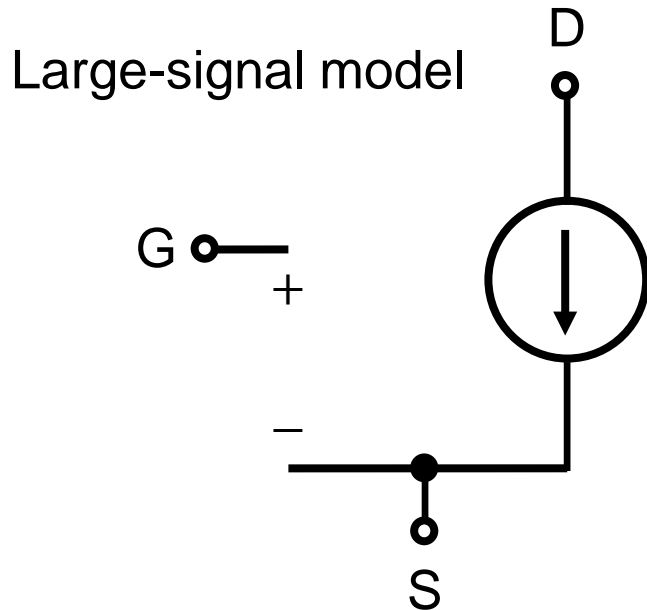
Small-signal current

- Using the transconductance (g_m) and the output resistance (r_o),
 - The small-signal drain current is given as $i_D = g_m v_G + \frac{v_D}{r_o}$.
 - When we build a small-signal model, two contributions must be separately considered.



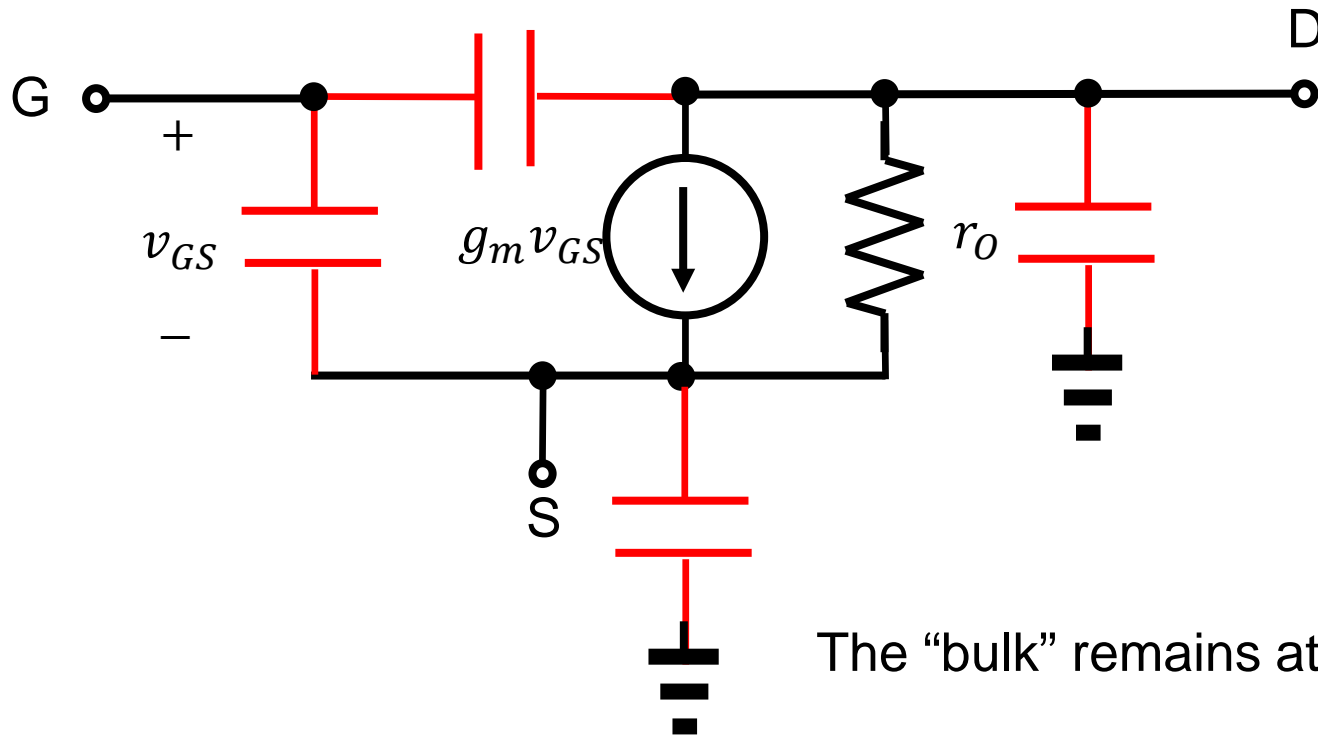
Small-signal model

- For small-signal analysis, a small-signal model for the MOSFET is introduced.



Time-dependent one?

- In general, capacitive components can be seen.



At low frequencies

- Capacitor current is $I = C \frac{dV}{dt}$.
 - When a sinusoidal dependence, for example $\sin \omega t$, is assumed, the capacitor current is proportional to ω .
 - At low frequencies, ω can be regarded as a small number.
 - In other words, the electric conduction between two nodes becomes rather weak.
 - Therefore, we often neglect the capacitive components in the small-signal model.
 - Of course, at higher frequencies, they become very important.